

30V N-Channel Enhancement-Mode MOSFET 30V N 沟道增强型 MOS 管

**VDS = 30V**

**RDS(ON), Vgs@10V, Ids@) 'SA = 40mΩ**

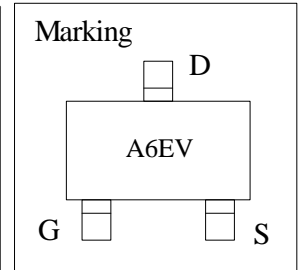
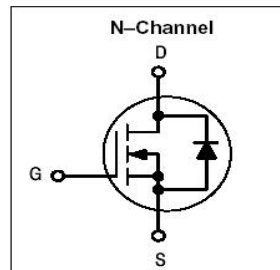
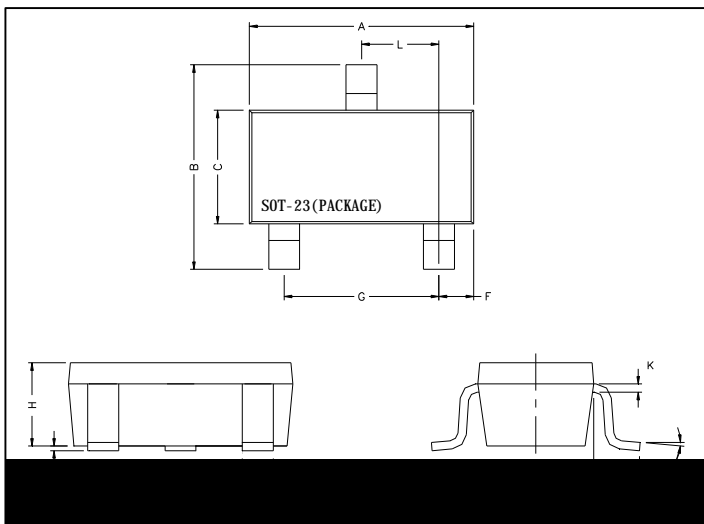
**RDS(ON), Vgs@4.5V, Ids@2.8A = 60mΩ**

**Features 特性**

Advanced trench process technology 高级的加工技术

High Density Cell Design For Ultra Low On-Resistance 极低的导通电阻高密度的单元设计

**Package Dimensions 封装尺寸及外形图**



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	1.90	REF.
B	2.40	2.80	H	1.00	1.30
C	1.40	1.60	K	0.10	0.20
D	0.35	0.50	J	0.40	-
E	0	0.10	L	0.85	1.15
F	0.45	0.55	M	0°	10°

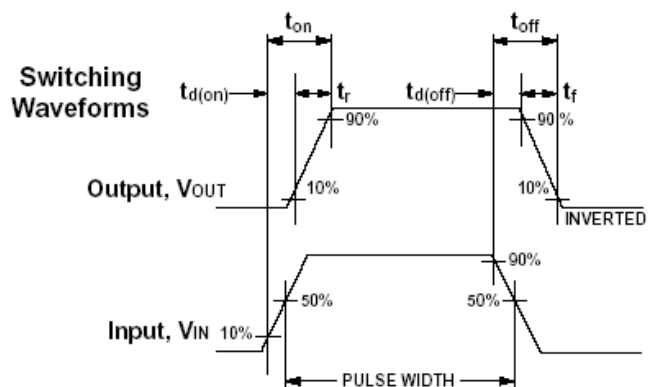
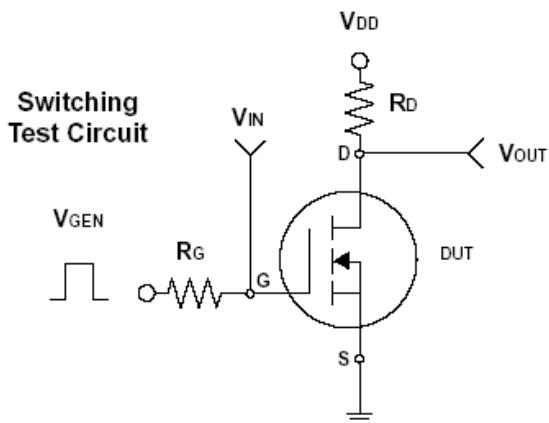
**Maximum Ratings and Thermal Characteristics (TA = 25°C unless otherwise noted) 25°C 极限参数和热特性**

Parameter 极限参数	Symbol 符号	Limit 范围	Unit 单位	
Drain-Source Voltage 漏源电压	V <sub>DS</sub>	30	V	
Gate-Source Voltage 栅源电压	V <sub>GS</sub>	± 20		
Continuous Drain Current 连续漏极电流	I <sub>D</sub>	5.0	A	
Pulsed Drain Current 脉冲漏极电流	I <sub>DM</sub>	18		
Maximum Power Dissipation 最大耗散功率	P <sub>D</sub>	TA = 25°C	1.4	W
		TA = 75°C	0.9	
Operating Junction and Storage Temperature Range 使用及储存温度	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C	
Junction-to-Ambient Thermal Resistance (PCB mounted) 结环热阻	R <sub>θJA</sub>	145	°C/W	

**ELECTRICAL CHARACTERISTICS** 一般电气特性

Parameter 参数	符号	Test Condition 测试条件	最小值	典型值	最大值	单位
<b>Static 静态参数</b>						
Drain-Source Breakdown Voltage 漏源击穿电压	$BV_{DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	30			V
Drain-Source On-State Resistance 漏源导通电阻	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 5.0A$		25	40	mΩ
Drain-Source On-State Resistance 漏源导通电阻	$R_{DS(on)}$	$V_{GS} = 4.5V, I_D = 2.8A$		45	60	
Gate Threshold Voltage 开启电压	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.0	1.5	3.0	V
Zero Gate Voltage Drain Current 零栅压漏极电流	$I_{DSS}$	$V_{DS} = 30V, V_{GS} = 0V$			1	uA
Gate Body Leakage 漏极短路时截止栅电流	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
Forward Transconductance 正向跨导	$g_{fs}$	$V_{DS} = 5V, I_D = 5.0A$		15		S
Gate Resistance	$R_g$	$F=1.0MHz$		6		Ω
<b>Dynamic 动态参数</b>						
Total Gate Charge 栅极总电荷	$Q_g$	$V_{DS} = 15V, I_D = 5.0A$ $V_{GS} = 10V$		6.9		nC
Gate-Source Charge 栅-源极电荷	$Q_{gs}$			0.65		
Gate-Drain Charge 栅-漏极电荷	$Q_{gd}$			1.89		
Turn-On Delay Time 导通延迟时间	$t_{d(on)}$	$V_{DD} = 15V, R_L = 2.7\Omega$ $I_D = 1A, V_{GEN} = 10V$ $R_G = 3\Omega$		7.4		ns
Turn-On Rise Time 导通上升时间	$t_r$			12.1		
Turn-Off Delay Time 关断延迟时间	$t_{d(off)}$			32.3		
Turn-Off Fall Time 关断下降时间	$t_f$			7.9		
Input Capacitance 输入电容	$C_{iss}$	$V_{DS} = 10V, V_{GS} = 0V$ $f = 1.0 MHz$		336		pF
Output Capacitance 输出电容	$C_{oss}$			46		
Reverse Transfer Capacitance 反向传输电容	$C_{rss}$			39.3		
<b>Source-Drain Diode 源漏二极管参数</b>						
Max. Diode Forward Current 最大正向电流	$I_S$				1.6	A
Diode Forward Voltage 正向电压	$V_{SD}$	$I_S = 1.6A, V_{GS} = 0V$			1.2	V

Note: Pulse test: pulse width ≤ 300us, duty cycle ≤ 2% 注意: 脉冲测试: 脉冲宽度 ≤ 300us 死区 ≤ 2%



Characteristics Curve 电气性能特征曲线

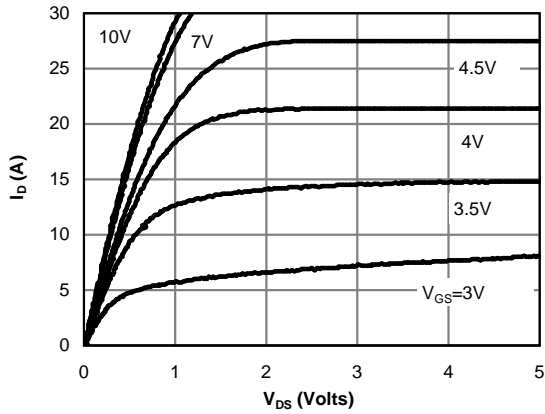


Fig 1: On-Region Characteristics (Note E)

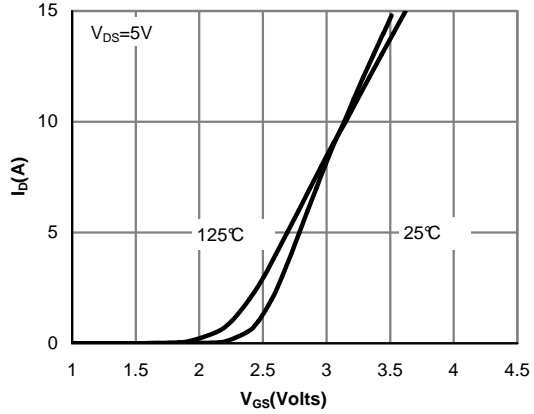


Figure 2: Transfer Characteristics (Note E)

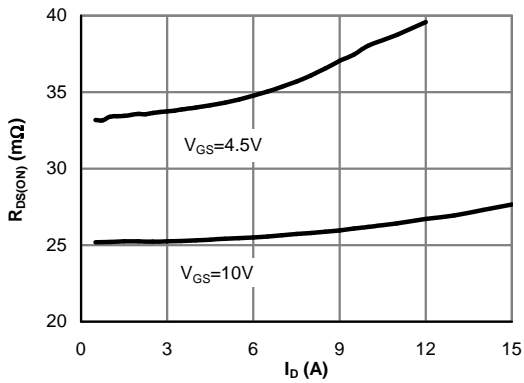


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

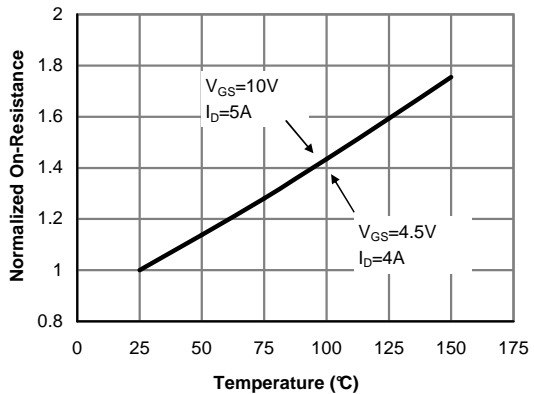


Figure 4: On-Resistance vs. Junction Temperature (Note E)

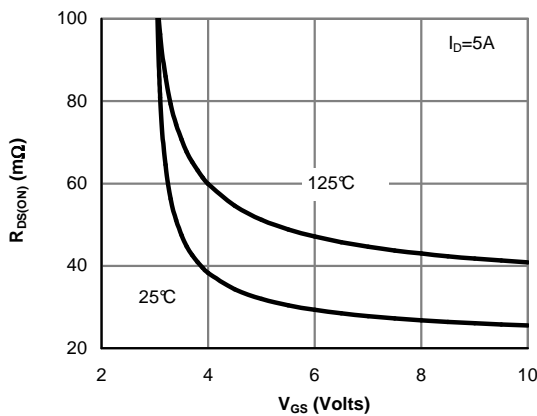


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

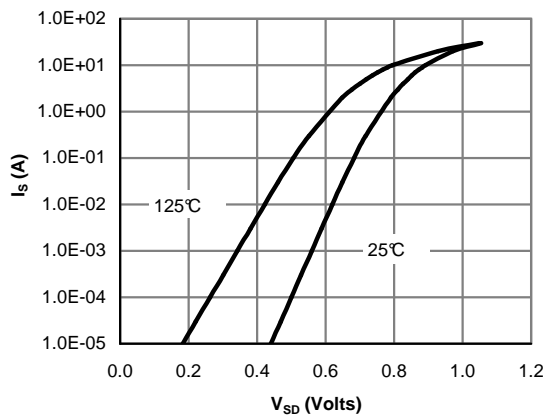


Figure 6: Body-Diode Characteristics (Note E)